

M48Z128 M48Z128Y, M48Z128V*

5.0V OR 3.3V, 1 Mbit (128 Kbit x 8) ZEROPOWER® SRAM

FEATURES SUMMARY

- INTEGRATED, ULTRA LOW POWER SRAM, POWER-FAIL CONTROL CIRCUIT, and BATTERY
- CONVENTIONAL SRAM OPERATION;
 UNLIMITED WRITE CYCLES
- 10 YEARS OF DATA RETENTION IN THE ABSENCE OF POWER
- BATTERY INTERNALLY ISOLATED UNTIL POWER IS FIRST APPLIED
- AUTOMATIC POWER-FAIL CHIP DESELECT and WRITE PROTECTION
- WRITE PROTECT VOLTAGES: (V_{PFD} = Power-fail Deselect Voltage)
 - M48Z128: $V_{CC} = 4.75$ to 5.5V 4.5V $\leq V_{PED} \leq 4.75$ V
 - M48Z128Y: V_{CC} = 4.5 to 5.5V 4.2V $\leq V_{PFD} \leq 4.5V$
 - M48Z128V: V_{CC} = 3.0 to 3.6V 2.8V $\leq V_{PFD} \leq 3.0$ V
- EQUIVALENT SURFACE-MOUNT (SMT)
 SOLUTION (Figure 2) INCLUDES A 28-PIN
 SOIC and A 32-LEAD TSOP (SNAPHAT® Top to be ordered separately)
- SOIC PACKAGE PROVIDES DIRECT CONNECTION FOR A SNAPHAT TOP WHICH CONTAINS THE BATTERY
- SNAPHAT HOUSING (BATTERY) IS REPLACEABLE
- PIN and FUNCTION COMPATIBLE WITH JEDEC STANDARD 128K x 8 SRAMs

Figure 1. 32-pin PMDIP Module

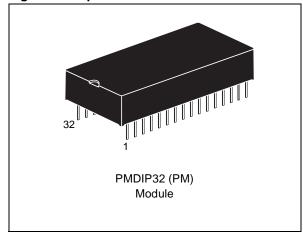
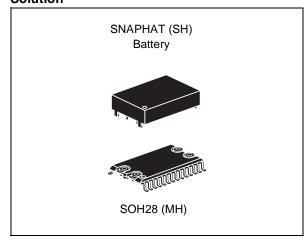
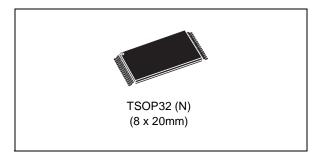


Figure 2. Equivalent Surface-Mount (SMT) Solution





March 2003 1/22

^{*} Contact Local Sales Office

TABLE OF CONTENTS

DESCRIPTION	3
Logic Diagram (Figure 3.) Signal Names (Table 1.) DIP Connections (Figure 4.)	3
Block Diagram (Figure 5.)	
Hardware Hookup for Equivalent Surface-Mount (SMT) Solution (Figure 6.)	
Equivalent Surface-Mount (SMT) Solution (Table 2.)	
MAXIMUM RATING	6
Absolute Maximum Ratings (Table 3.)	6
DC AND AC PARAMETERS	7
Operating and AC Measurement Conditions (Table 4.)	7
AC Measurement Load Circuit (Figure 7.)	7
Capacitance (Table 5.)	
DC Characteristics (Table 6.)	8
OPERATING MODES	8
Operating Modes (Table 7.)	8
READ Mode	9
Chip Enable or Output Enable Controlled, READ Mode AC Waveforms (Figure 8.)	
Address Controlled, READ Mode AC Waveforms (Figure 9.)	
READ Mode AC Characteristics (Table 8.)	10
WRITE Mode	
WRITE Enable Controlled, WRITE AC Waveforms (Figure 10.)	
Chip Enable Controlled, WRITE AC Waveforms (Figure 11.)	
WRITE Mode AC Characteristics (Table 9.)	12
Data Retention Mode	13
Power Down/Up Mode AC Waveforms (Figure 12.)	
Power Down/Up AC Characteristics (Table 10.)	
Power Down/Up Trip Points DC Characteristics (Table 11.)	14
V _{CC} Noise And Negative Going Transients	
Supply Voltage Protection (Figure 13.)	14
PACKAGE MECHANICAL INFORMATION	15
PART NUMBERING	20
SNAPHAT Battery Table (Table 18.)	20
REVISION HISTORY	21

DESCRIPTION

The M48Z128/Y/V ZEROPOWER® RAM is a 128 Kbit x 8 non-volatile static RAM organized as131,072 words by 8 bits. The device combines an internal lithium battery, a CMOS SRAM and a control circuit in a plastic, 32-pin DIP module. This solution is available in two special packages to provide a highly integrated battery backed-up memory solution.

The M48Z128/Y/V is a non-volatile pin and function equivalent to any JEDEC standard 128K x 8 SRAM. It also easily fits into many ROM, EPROM, and EEPROM sockets, providing the non-volatility of PROMs without any requirement for special WRITE timing or limitations on the number of WRITEs that can be performed. The 32-pin, 600mil DIP Module houses the M48Z128/Y/V silicon with a long life lithium button cell in a single package.

For surface-mount environments ST provides an equivalent SMT solution consisting of a 28-pin, 330mil SOIC NVRAM SUPERVISOR (M40Z300/

W) and a 32-pin TSOP (8 x 20mm) LPSRAM (M68Z128/W) packages. Both 5V and 3V versions are available (see Table 2, page 5).

The 28-pin, 330mil SOIC provides sockets with gold plated contacts at both ends for direct connection to a separate SNAPHAT® housing containing the battery.

The unique design allows the SNAPHAT battery package to be mounted on top of the SOIC package after the completion of the surface-mount process. Insertion of the SNAPHAT housing after reflow prevents potential battery damage due to the high temperatures required for device surface-mounting. The SNAPHAT housing is keyed to prevent reverse insertion.

The SNAPHAT battery package is shipped separately in plastic anti-static tubes or in Tape & Reel form. The part number is "M4Zxx-BR00SH" (see Table 18, page 20).

Figure 3. Logic Diagram

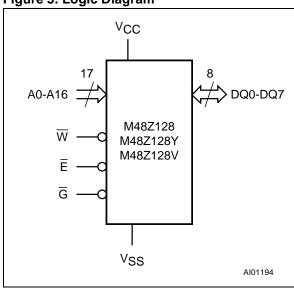


Table 1. Signal Names

A0-A16	Address Inputs
DQ0-DQ7	Data Inputs / Outputs
Ē	Chip Enable Input
G	Output Enable Input
W	WRITE Enable Input
V _{CC}	Supply Voltage
V _{SS}	Ground
NC	Not Connected Internally

Figure 4. DIP Connections

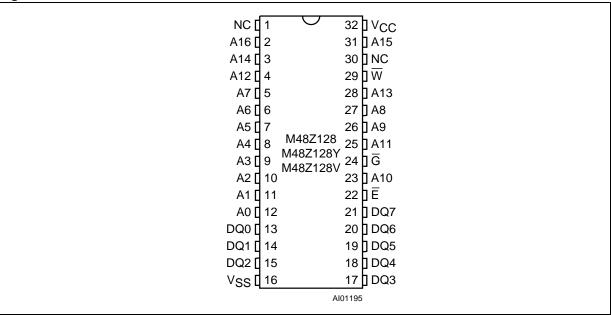
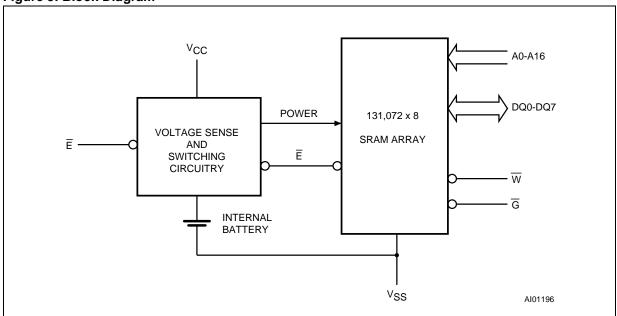


Figure 5. Block Diagram



47/

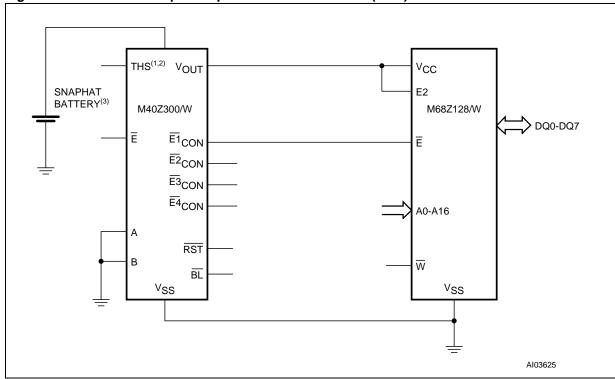


Figure 6. Hardware Hookup for Equivalent Surface-Mount (SMT) Solution

Note: For pin connections, see individual data sheets for M48Z300/300W and M68Z128/128W at www.st.com.

- 1. Connect THS pin to V_{OUT} if $4.2V \le V_{PFD} \le 4.5V$ (M48Z128Y) or connect THS pin to V_{SS} if $4.5V \le V_{PFD} \le 4.75V$ (M48Z128V). 2. Connect THS pin to V_{SS} if $2.8V \le V_{PFD} \le 3.0V$ (M48Z128V). 3. SNAPHAT® Top ordered separately.

Table 2. Equivalent Surface-Mount (SMT) Solution

<u> </u>	· ,		
NVRAM	LPSRAM	SUPERVISOR	THS Pin ⁽¹⁾
M48Z128	M68Z128	M40Z300	V _{SS}
M48Z128Y	M68Z128	M40Z300	V _{OUT}
M48Z128V	M68Z128W	M40Z300W	V_{SS}

Note: 1. Connection of Threshold Select Pin (Pin 13) of SUPERVISOR (M40Z300/300W).

MAXIMUM RATING

Stressing the device above the rating listed in the "Absolute Maximum Ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is

not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 3. Absolute Maximum Ratings

Symbol	Parameter	Value	Unit	
T _A	Ambient Operating Temperature		0 to 70	°C
T _{STG}	Storage Temperature (V _{CC} Off, Oscillator Off)		-40 to 85	°C
T _{BIAS}	Temperature Under Bias		-10 to 70	°C
T _{SLD} ^(1,2)	Lead Solder Temperature for 10 seconds	260	°C	
V _{IO}	Input or Output Voltages		-0.3 to 7	V
Vcc	Supply Voltage	M48Z128/Y	-0.3 to 7.0	V
VCC	Supply Vollage	M48Z128V	-0.3 to 4.6	V
lo	Output Current		20	mA
P _D	Power Dissipation		1	W

Note: 1. For DIP package: Soldering temperature not to exceed 260°C for 10 seconds (total thermal budget not to exceed 150°C for longer than 30 seconds).

CAUTION: Negative undershoots below –0.3V are not allowed on any pin while in the Battery Back-up mode. **CAUTION:** Do NOT wave solder SOIC to avoid damaging SNAPHAT sockets.

^{2.} For SO package: Reflow at peak temperature of 215°C to 225°C for < 60 seconds (total thermal budget not to exceed 180°C for between 90 to 120 seconds).

DC AND AC PARAMETERS

This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC Characteristic tables are derived from tests performed under the Measure-

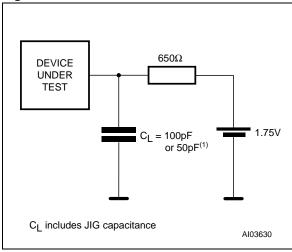
ment Conditions listed in the relevant tables. Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

Table 4. Operating and AC Measurement Conditions

Parameter	M48Z128/Y	M48Z128V	Unit
Supply Voltage (V _{CC})	4.75 to 5.5V or 4.5 to 5.5	3.0 to 3.6	V
Ambient Operating Temperature (T _A)	0 to 70	0 to 70	°C
Load Capacitance (C _L)	100	50	pF
Input Rise and Fall Times	≤ 5	≤ 5	ns
Input Pulse Voltages	0 to 3	0 to 3	V
Input and Output Timing Ref. Voltages	1.5	1.5	V

Note: Output Hi-Z is defined as the point where data is no longer driven.

Figure 7. AC Measurement Load Circuit



Note: 1. 50pF for M48Z128V (3.3V).

Table 5. Capacitance

Symbol	Parameter ^(1,2)	Min	Max	Unit
C _{IN}	Input Capacitance		10	pF
C _{IO} (3)	Input / Output Capacitance		10	pF

Note: 1. Effective capacitance measured with power supply at 5V (M48Z128/Y) or 3.3V (M48Z128V); sampled only, not 100% tested.

- 2. At 25°C, f = 1MHz.
- 3. Outputs deselected.



Table 6. DC Characteristics

			M48	3Z128/Y	M48		
Sym	Sym Parameter Test Condition ⁽¹⁾		-70 / -	-85 / -120	-85	Unit	
			Min	Max	Min	Max	
ILI	Input Leakage Current	$0V \leq V_{IN} \leq V_{CC}$		±1		±1	μΑ
I _{LO} ⁽²⁾	Output Leakage Current	$0V \le V_{OUT} \le V_{CC}$		±1		±1	μΑ
I _{CC}	Supply Current	$\overline{E} = V_{IL}$ Outputs open		105		50	mA
I _{CC1}	Supply Current (Standby) TTL	E = V _{IH}		7		4	mA
I _{CC2}	Supply Current (Standby) CMOS	$\overline{E} = V_{CC} - 0.2V$		4		3	mA
V _{IL}	Input Low Voltage		-0.3	0.8	-0.3	0.6	V
V _{IH}	Input High Voltage		2.2	V _{CC} + 0.3	2.2	V _{CC} + 0.3	V
V _{OL}	Output Low Voltage	I _{OL} = 2.1mA		0.4		0.4	V
V _{OH}	Output High Voltage	$I_{OH} = -1mA$	2.4		2.2		V

Note: 1. Valid for Ambient Operating Temperature: $T_A = 0$ to 70° C; $V_{CC} = 4.75$ to 5.5V, 4.5 to 5.5V, or 3.0 to 3.6V (except where noted).

OPERATING MODES

The M48Z128/Y/V also has its own Power-fail Detect circuit. The control circuitry constantly monitors the single V_{CC} supply for an out of tolerance condition. When V_{CC} is out of tolerance, the circuit write protects the SRAM, providing a high degree

of data security in the midst of unpredictable system operation brought on by low V_{CC} . As V_{CC} falls below the switchover voltage (V_{SO}), the control circuitry connects the battery which maintains data until valid power returns.

Table 7. Operating Modes

Mode	Vcc	Ē	G	W	DQ0-DQ7	Power
Deselect	4.75 to 5.5V	V _{IH}	Х	Х	High Z	Standby
WRITE	or 4.5 to 5.5V	V _{IL}	Х	V _{IL}	D _{IN}	Active
READ	or	V _{IL}	V _{IL}	V _{IH}	D _{OUT}	Active
READ	3.0 to 3.6V	V _{IL}	V _{IH}	V _{IH}	High Z	Active
Deselect	V _{SO} to V _{PFD} (min) ⁽¹⁾	Х	Х	Х	High Z	CMOS Standby
Deselect	≤ V _{SO} ⁽¹⁾	Х	Х	Х	High Z	Battery Back-up Mode

Note: $X = V_{IH}$ or V_{IL} ; $V_{SO} = Battery Back-up Switchover Voltage.$

47/

^{2.} Outputs deselected.

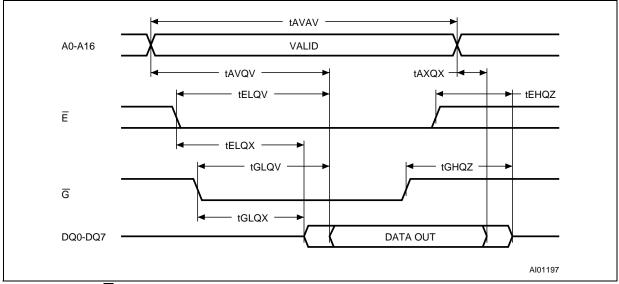
^{1.} See Table 11, page 14 for details.

READ Mode

The M48Z128/Y/V is in the READ Mode whenever \overline{W} (WRITE Enable) is high and \overline{E} (Chip Enable) is low. The device architecture allows ripple-through access of data from eight of 1,048,576 locations in the static storage array. Thus, the unique address specified by the 17 address inputs defines which one of the 131,072 bytes of data is to be accessed. Valid data will be available at the Data I/O pins within Address Access time (t_{AVQV}) after the last address input signal is stable, providing that the \overline{E} and \overline{G} (Output Enable) access times are also sat-

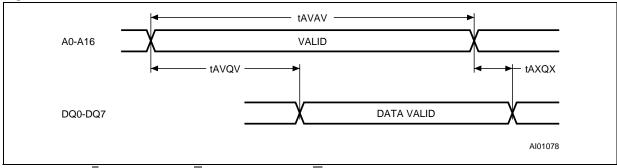
isfied. If the \overline{E} and \overline{G} access times are not met, valid data will be available after the later of Chip Enable Access time (t_{ELQV}) or Output Enable Access Time (t_{GLQV}). The state of the eight three-state Data I/O signals is controlled by \overline{E} and \overline{G} . If the outputs are activated before t_{AVQV} , the data lines will be driven to an indeterminate state until t_{AVQV} . If the address inputs are changed while \overline{E} and \overline{G} remain low, output data will remain valid for Output Data Hold time (t_{AXQX}) but will go indeterminate until the next Address Access.

Figure 8. Chip Enable or Output Enable Controlled, READ Mode AC Waveforms



Note: WRITE Enable (\overline{W}) = High.

Figure 9. Address Controlled, READ Mode AC Waveforms



Note: Chip Enable (\overline{E}) and Output Enable (\overline{G}) = Low, WRITE Enable (\overline{W}) = High.

Table 8. READ Mode AC Characteristics

			M48Z128/Y		28/Y/V	M48Z128/Y/V -120		Unit
Symbol	Parameter ⁽¹⁾	-70		-85				
		Min	Max	Min	Max	Min	Max	
t _{AVAV}	READ Cycle Time	70		85		120		ns
t _{AVQV}	Address Valid to Output Valid		70		85		120	ns
t _{ELQV}	Chip Enable Low to Output Valid		70		85		120	ns
t _{GLQV}	Output Enable Low to Output Valid		35		45		60	ns
t _{ELQX} ⁽²⁾	Chip Enable Low to Output Transition	5		5		5		ns
t _{GLQX} ⁽²⁾	Output Enable Low to Output Transition	3		3		3		ns
t _{EHQZ} (2)	Chip Enable High to Output Hi-Z		30		35		45	ns
t _{GHQZ} ⁽²⁾	Output Enable High to Output Hi-Z		20		25		35	ns
taxqx	Address Transition to Output Transition	5		5		10		ns

Note: 1. Valid for Ambient Operating Temperature: T_A = 0 to 70°C; V_{CC} = 4.75 to 5.5V, 4.5 to 5.5V, or 3.0 to 3.6V (except where noted). 2. C_L = 5pF.

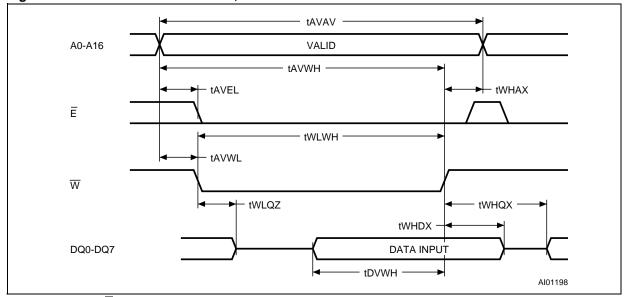
WRITE Mode

The M48Z128/Y/V is in the WRITE Mode whenever \overline{W} and \overline{E} are active. The start of a WRITE is referenced from the latter occurring falling edge of \overline{W} or \overline{E} . A WRITE is terminated by the earlier rising edge of \overline{W} or \overline{E} .

The addresses must be held valid throughout the cycle. E or W must return high for minimum of tehax from E or twhax from W prior to the initiation

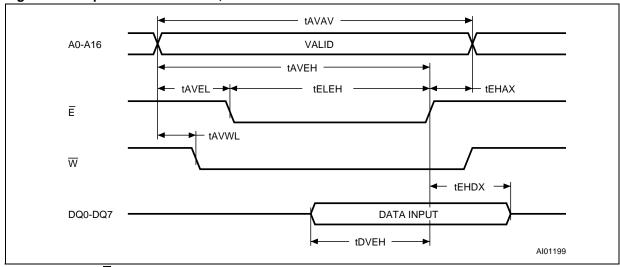
of another READ or WRITE cycle. Data-in must be valid t_{DVWH} prior to the end of WRITE and remain valid for t_{WHDX} or t_{EHDX} afterward. \overline{G} should be kept high during WRITE cycles to avoid bus contention; although, if the output bus has been activated by a low on \overline{E} and \overline{G} , a low on \overline{W} will disable the outputs t_{WLQZ} after \overline{W} falls.

Figure 10. WRITE Enable Controlled, WRITE AC Waveforms



Note: Output Enable (\overline{G}) = High.

Figure 11. Chip Enable Controlled, WRITE AC Waveforms



Note: Output Enable (\overline{G}) = High.

Table 9. WRITE Mode AC Characteristics

	Symbol Parameter ⁽¹⁾		M48Z128/Y -70		28/Y/V	M48Z128/Y/V -120		Unit
Symbol					35			
		Min	Max	Min	Max	Min	Max	
t _{AVAV}	WRITE Cycle Time	70		85		120		ns
t _{AVWL}	Address Valid to WRITE Enable Low	0		0		0		ns
t _{AVEL}	Address Valid to Chip Enable Low	0		0		0		ns
twLwH	WRITE Enable Pulse Width	55		65		85		ns
tELEH	Chip Enable Low to Chip Enable High	55		75		100		ns
t _{WHAX}	WRITE Enable High to Address Transition	5		5		5		ns
t _{EHAX}	Chip Enable High to Address Transition	15		15		15		ns
t _{DVWH}	Input Valid to WRITE Enable High	30		35		45		ns
t _{DVEH}	Input Valid to Chip Enable High	30		35		45		ns
t _{WHDX}	WRITE Enable High to Input Transition	0		0		0		ns
t _{EHDX}	Chip Enable High to Input Transition	10		10		10		ns
t _{WLQZ} (2,3)	WRITE Enable Low to Output Hi-Z		25		30		40	ns
t _{AVWH}	Address Valid to WRITE Enable High	65		75		100		ns
t _{AVEH}	Address Valid to Chip Enable High	65		75		100		ns
twHQX ^(2,3)	WRITE Enable High to Output Transition	5		5		5		ns

Note: 1. Valid for Ambient Operating Temperature: T_A = 0 to 70°C; V_{CC} = 4.75 to 5.5V, 4.5 to 5.5V or 3.0 to 3.6V (except where noted).

2. C_L = 5pF.

3. If E goes low simultaneously with W going low, the outputs remain in the high impedance state.

Data Retention Mode

With valid V_{CC} applied, the M48Z128/Y/V operates as a conventional BYTEWIDETM static RAM. Should the supply voltage decay, the RAM will automatically power-fail deselect, write protecting itself t_{WP} after V_{CC} falls below V_{PFD} . All outputs become high impedance, and all inputs are treated as "Don't care."

If power fail detection occurs during a valid access, the memory cycle continues to completion. If the memory cycle fails to terminate within the time t_{WP} , write protection takes place. When V_{CC} drops below V_{SO} , the control circuit switches power to the internal energy source which preserves data.

The internal coin cell will maintain data in the M48Z128/Y/V after the initial application of V_{CC} for an accumulated period of at least 10 years when V_{CC} is less than V_{SO} . As system power returns and V_{CC} rises above V_{SO} , the battery is disconnected, and the power supply is switched to external V_{CC} . Write protection continues for t_{ER} after V_{CC} reaches V_{PFD} to allow for processor stabilization. After t_{ER} , normal RAM operation can resume. For more information on Battery Storage Life refer to the Application Note AN1012.

Figure 12. Power Down/Up Mode AC Waveforms

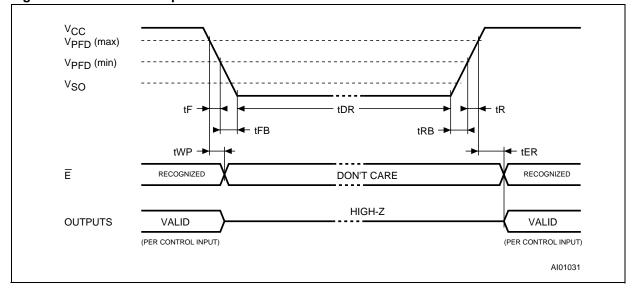


Table 10. Power Down/Up AC Characteristics

Symbol	Parameter ⁽¹⁾			Max	Unit
t _F ⁽²⁾	V _{PFD} (max) to V _{PFD} (min) V _{CC} Fall Time		300		μs
t _{FB} ⁽³⁾	M48Z128/Y		10		110
ξFB ^(*)	V _{PFD} (min) to V _{SS} V _{CC} Fall Time	M48Z128V	150		μs
t _R	V _{PFD} (min) to V _{PFD} (max) V _{CC} Rise Time		10		μs
t _{RB}	V _{SS} to V _{PFD} (min) V _{CC} Rise Time		1		μs
twp	Write Protect Time	M48Z128/Y	40	150	II.C
ιWΡ	White Protect Time	M48Z128V	40	250	μs
t _{ER}	E Recovery Time		40	120	ms

Note: 1. Valid for Ambient Operating Temperature: $T_A = 0$ to $70^{\circ}C$; $V_{CC} = 4.75$ to 5.5V, 4.5 to 5.5V, or 3.0 to 3.6V (except where noted).

^{3.} VPFD (min) to VSS fall time of less than tFB may cause corruption of RAM data.



V_{PFD} (max) to V_{PFD} (min) fall time of less than t_F may result in deselection/write protection not occurring until 200µs after V_{CC} passes V_{PFD} (min).

Table 11. Power Down/Up Trip Points DC Characteristics

Symbol	Parameter ^(1,2)		Min	Тур	Max	Unit
		M48Z128	4.5	4.6	4.75	V
V_{PFD}		M48Z128Y	4.2	4.3	4.5	V
		M48Z128V	2.8	2.9	3.0	V
Voo	V _{SO} Battery Back-up Switchover Voltage	M48Z128/Y		3.0		V
VSO		M48Z128V		2.5		V
t _{DR} ⁽³⁾	Expected Data Retention Time		10			YEARS

Note: 1. All voltages referenced to VSS.

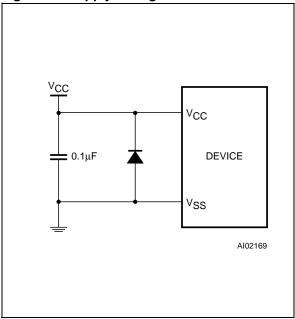
- 2. Valid for Ambient Operating Temperature: T_A = 0 to 70°C; V_{CC} = 4.75 to 5.5V, 4.5 to 5.5V, or 3.0 to 3.6V (except where noted).
- 3. At 25°C; V_{CC} = 0V.

V_{CC} Noise And Negative Going Transients

 I_{CC} transients, including those produced by output switching, can produce voltage fluctuations, resulting in spikes on the V_{CC} bus. These transients can be reduced if capacitors are used to store energy which stabilizes the V_{CC} bus. The energy stored in the bypass capacitors will be released as low going spikes are generated or energy will be absorbed when overshoots occur. A ceramic bypass capacitor value of $0.1\mu F$ (see Figure 13) is recommended in order to provide the needed filtering.

In addition to transients that are caused by normal SRAM operation, power cycling can generate negative voltage spikes on V_{CC} that drive it to values below V_{SS} by as much as one volt. These negative spikes can cause data corruption in the SRAM while in battery backup mode. To protect from these voltage spikes, ST recommends connecting a schottky diode from V_{CC} to V_{SS} (cathode connected to V_{CC} , anode to V_{SS}). (Schottky diode 1N5817 is recommended for through hole and MBRS120T3 is recommended for surface-mount).

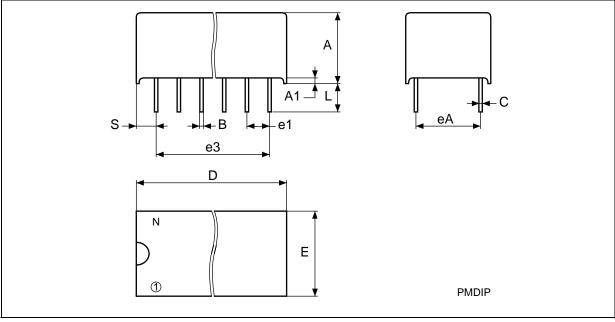
Figure 13. Supply Voltage Protection



57

PACKAGE MECHANICAL INFORMATION

Figure 14. PMDIP32 – 32-pin Plastic DIP Module, Package Outline



Note: Drawing is not to scale.

Table 12. PMDIP32 – 32-pin Plastic DIP Module, Package Mechanical Data

Symb		mm		inches			
	Тур	Min	Max	Тур	Min	Max	
А		9.27	9.52		0.365	0.375	
A1		0.38	_		0.015	_	
В		0.43	0.59		0.017	0.023	
С		0.20	0.33		0.008	0.013	
D		42.42	43.18		1.670	1.700	
E		18.03	18.80		0.710	0.740	
e1		2.29	2.79		0.090	0.110	
e3		34.29	41.91		1.350	1.650	
eA		14.99	16.00		0.590	0.630	
L		3.05	3.81		0.120	0.150	
S		1.91	2.79		0.075	0.110	
N		32			32		

477

B P C CP P P C CP P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P P C P C P P C P C P P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P C P

Figure 15. SOH28 – 28-lead Plastic Small Outline, battery SNAPHAT, Package Outline

Table 13. SOH28 – 28-lead Plastic Small Outline, battery SNAPHAT, Package Mechanical Data

Symbol	mm			inch		
	Тур	Min	Max	Тур	Min	Max
Α			3.05			0.120
A1		0.05	0.36		0.002	0.014
A2		2.34	2.69		0.092	0.106
В		0.36	0.51		0.014	0.020
С		0.15	0.32		0.006	0.012
D		17.71	18.49		0.697	0.728
E		8.23	8.89		0.324	0.350
е	1.27	_	-	0.050	_	-
eB		3.20	3.61		0.126	0.142
Н		11.51	12.70		0.453	0.500
L		0.41	1.27		0.016	0.050
α		0°	8°		0°	8°
N		28			28	•
СР			0.10			0.004

Figure 16. SH – 4-pin SNAPHAT Housing for 48mAh Battery, Package Outline

Table 14. SH – 4-pin SNAPHAT Housing for 48mAh Battery, Package Mechanical Data

		man medeling ie	u. D atto	. y, . aonago n	oonamoa. Data	
Symb	mm			inches		
	Тур	Min	Max	Тур	Min	Max
А			9.78			0.385
A1		6.73	7.24		0.265	0.285
A2		6.48	6.99		0.255	0.275
А3			0.38			0.015
В		0.46	0.56		0.018	0.022
D		21.21	21.84		0.835	0.860
E		14.22	14.99		0.560	0.590
eA		15.55	15.95		0.612	0.628
eB		3.20	3.61		0.126	0.142
L		2.03	2.29		0.080	0.090

Figure 17. SH – 4-pin SNAPHAT Housing for 120mAh Battery, Package Outline

Table 15. SH – 4-pin SNAPHAT Housing for 120mAh Battery, Package Mechanical Data

Symb	mm			inches			
	Тур	Min	Max	Тур	Min	Max	
Α			10.54			0.415	
A1		8.00	8.51		0.315	0.335	
A2		7.24	8.00		0.285	0.315	
А3			0.38			0.015	
В		0.46	0.56		0.018	0.022	
D		21.21	21.84		0.835	0.860	
E		17.27	18.03		0.680	0.710	
eA		15.55	15.95		0.612	0.628	
еВ		3.20	3.61		0.126	0.142	
L		2.03	2.29		0.080	0.090	

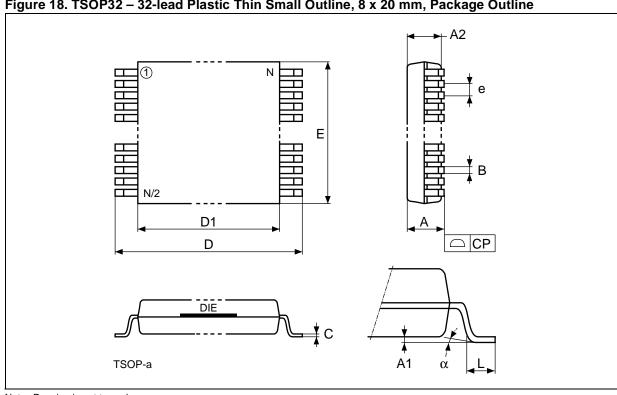


Figure 18. TSOP32 - 32-lead Plastic Thin Small Outline, 8 x 20 mm, Package Outline

Table 16. TSOP32 - 32-lead Plastic Thin Small Outline, 8 x 20 mm, Package Mechanical Data

Symb	mm			inches		
	Тур	Min	Max	Тур	Min	Max
А			1.200			0.0472
A1		0.050	0.150		0.0020	0.0059
A2		0.950	1.050		0.0374	0.0413
В		0.150	0.270		0.0059	0.0106
С		0.100	0.210		0.0039	0.0083
D		19.800	20.200		0.7795	0.7953
D1		18.300	18.500		0.7205	0.7283
е	0.500	_	-	0.0197	_	-
E		7.900	8.100		0.3110	0.3189
L		0.500	0.700		0.0197	0.0276
α		0°	5°		0°	5°
СР			0.100			0.0039
N	32		32			

PART NUMBERING

Table 17. Ordering Information Scheme

Example: M48Z 128Y

Device Type

M48Z

Supply Voltage and Write Protect Voltage

 $128 = V_{CC} = 4.75 \text{ to } 5.5V; V_{PFD} = 4.5 \text{ to } 4.75V$

 $128Y = V_{CC} = 4.5 \text{ to } 5.5V; V_{PFD} = 4.2 \text{ to } 4.5V$

 $128V^{(1)} = V_{CC} = 3.0 \text{ to } 3.6V; V_{PFD} = 2.8 \text{ to } 3.0V$

Speed

-70 = 70ns (for M48Z128/Y)

-85 = 85ns (for M48Z128/Y/V)

-120 = 120ns (for M48Z128/Y/V)

Package⁽²⁾

PM = PMDIP32

Temperature Range

 $1 = 0 \text{ to } 70^{\circ}\text{C}$

Note: 1. Contact Local Sales Office

2. The SOIC package (SOH28) requires the battery package (SNAPHAT®) which is ordered separately under the part number "M4Zxx-BR00SH" in plastic tube or "M4Zxx-BR00SHTR" in Tape & Reel form.

Caution: Do not place the SNAPHAT battery package "M4Zxx-BR00SH" in conductive foam as it will drain the lithium button-cell battery.

-70

PM

For a list of available options (e.g., Speed, Package) or for further information on any aspect of this device, please contact the ST Sales Office nearest to you.

Table 18. SNAPHAT Battery Table

Part Number	Description	Package	
M4Z28-BR00SH	Lithium Battery (48mAh) SNAPHAT	SH	
M4Z32-BR00SH	Lithium Battery (120mAh) SNAPHAT	SH	

REVISION HISTORY

Table 19. Revision History

Date	Rev. #	Revision Details
May 1999	1.0	First Issue
13-Apr-00	2.0	Document Layout changed; surface-Mount Chip Set solution added
20-Jun-00	2.1	t _{GLQX} changed (Table 8)
19-Jul-00	2.2	M48Z128V added
14-Sep-01	3.0	Reformatted; added temperature information (Table 5, 6, 8, 9, 10, 11)
07-Nov-01	3.1	Remove chipset option from Ordering Information (Table 17)
20-May-02	3.2	Modify reflow time and temperature footnotes (Table 3)
18-Nov-02	3.3	Modifying SMT solution text (Figure 2, 6; Table 2)



Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

The ST logo is registered trademark of STMicroelectronics All other names are the property of their respective owners.

© 2003 STMicroelectronics - All Rights Reserved

STMicroelectronics GROUP OF COMPANIES

Australia - Brazil - Canada - China - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - U.S.A.

www.st.com

